

Notice of References Cited	Application/Control No. 10/606,258	Applicant(s)/Patent Under Reexamination CHIN ET AL.	
	Examiner Usmaan Saeed	Art Unit 2166	Page 1 of 1

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	B	US-6,720,194 B1	04-2004	Miller et al.	438/14
	C	US-2004/0128641 A1	07-2004	Broberg et al.	716/018
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Sedra et al. "Microelectronic circuits", Oxford University Press, 1998, Pages 354- 358
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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